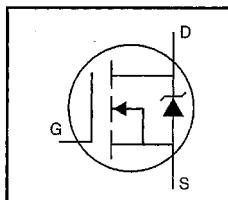


HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- 175°C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements

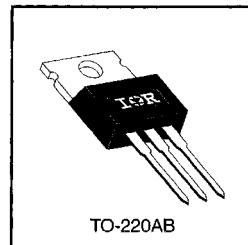


$V_{DSS} = 100V$
 $R_{DS(on)} = 0.077\Omega$
 $I_D = 28A$

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



DATA SHEETS

Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	28	
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	20	A
I_{DM}	Pulsed Drain Current ①	110	
$P_D @ T_C = 25^\circ C$	Power Dissipation	150	W
	Linear Derating Factor	1.0	W/ $^\circ C$
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy ②	230	mJ
I_{AR}	Avalanche Current ①	28	A
E_{AR}	Repetitive Avalanche Energy ①	15	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.5	V/ns
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to +175	$^\circ C$
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf-in (1.1 N·m)	

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
R_{eJC}	Junction-to-Case	—	—	1.0	
R_{eCS}	Case-to-Sink, Flat, Greased Surface	—	0.50	—	$^\circ C/W$
R_{eJA}	Junction-to-Ambient	—	—	62	

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{GS}=0\text{V}$, $I_D = 250\mu\text{A}$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.13	—	V°C	Reference to 25°C , $I_D = 1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.077	Ω	$V_{GS}=10\text{V}$, $I_D = 17\text{A}$ ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS}=V_{GS}$, $I_D = 250\mu\text{A}$
g_{fs}	Forward Transconductance	8.7	—	—	S	$V_{DS}=50\text{V}$, $I_D = 17\text{A}$ ④
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	μA	$V_{DS}=100\text{V}$, $V_{GS}=0\text{V}$
		—	—	250		$V_{DS}=80\text{V}$, $V_{GS}=0\text{V}$, $T_J = 150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS}=20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS}=-20\text{V}$
Q_g	Total Gate Charge	—	—	72	nC	$I_D = 17\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	11		$V_{DS}=80\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	32		$V_{GS}=10\text{V}$ See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	11	—		$V_{DD}=50\text{V}$
t_r	Rise Time	—	44	—	ns	$I_D = 17\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	53	—		$R_G=9.1\Omega$
t_f	Fall Time	—	43	—		$R_D=2.9\Omega$ See Figure 10 ④
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	1700	—		$V_{GS}=0\text{V}$
C_{oss}	Output Capacitance	—	560	—	pF	$V_{DS}=25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	120	—		$f=1.0\text{MHz}$ See Figure 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	28	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	110		
V_{SD}	Diode Forward Voltage	—	—	2.5		$T_J = 25^\circ\text{C}$, $I_S = 28\text{A}$, $V_{GS} = 0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	180	360	ns	$T_J = 25^\circ\text{C}$, $I_F = 17\text{A}$
Q_{rr}	Reverse Recovery Charge	—	1.3	2.8	μC	$dI/dt = 100\text{A}/\mu\text{s}$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)

③ $I_{SD} \leq 28\text{A}$, $di/dt \leq 170\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 175^\circ\text{C}$ ② $V_{DD}=25\text{V}$, starting $T_J=25^\circ\text{C}$, $L=440\mu\text{H}$ $R_G=25\Omega$, $I_{AS}=28\text{A}$ (See Figure 12)④ Pulse width $\leq 300\ \mu\text{s}$; duty cycle $\leq 2\%$.